FORM PTO-1449 (Rev. 2-32)	U.S. Department of Commerce Patent and Trademark Office	Atty. Docket No.	Serial No.
	INFORMATION DISCLOSURE STATEMENT BY APPLICANT	02-1002-A	To Be Assigned
	(Use several sheets if necessary)		
		Applicant:	
·	V	Jiang et al.	
	. *	Filing Date: Concurrently Herewith	Group:

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Examin r Initial	Document Number	Date	Name	Clas	Subclass	Filing Date if Appropriate
I.A.	5,355,215	10/11/94	Schroeder et al.			
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I.A.	Shealy, et al., "Design and analysis of aspherical multilayer imaging x-ray microscopic", Optical Engineering, Vol. 30, pp. 1094-1909 (1991).
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EXAMINER	1	*	
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